

UNISONIC TECHNOLOGIES CO., LTD

5N60-ML1

Preliminary

5.0A, 600V N-CHANNEL POWER MOSFET

DESCRIPTION

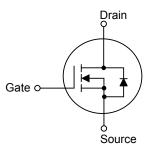
The UTC **5N60-ML1** is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

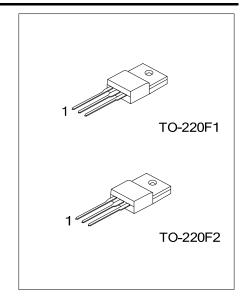
The UTC **5N60-ML1** is generally applied in high efficiency switch mode power supplies.

FEATURES

* $R_{DS(ON)} \le 2.5 \ \Omega \textcircled{O} V_{GS} = 10V, I_D = 2.5A$

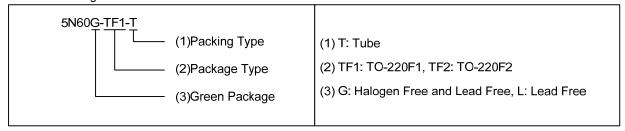
- * High Switching Speed
- SYMBOL



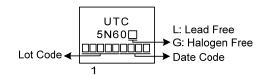


ORDERING INFORMATION

Ordering Number			Deelvere	Pin Assignment			Decking	
	Lead Free	Halogen Free	Package	1	2	3	Packing	
	5N60L-TF1-T	5N60G-TF1-T	TO-220F1	G	D	S	Tube	
	5N60L-TF2-T	5N60G-TF2-T	TO-220F2	G	D	S	Tube	
Note:	Pin Assignment: G: G							



MARKING



■ ABSOLUTE MAXIMUM RATINGS (T_c = 25°C, unless otherwise specified)

PAR	AMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	600	V
Gate-Source Voltage		V _{GSS}	±30	V
Drain Currant	Continuous	ID	5	А
Drain Current	Pulsed (Note 2)	I _{DM}	10	А
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	172.8	mJ
Peak Diode Recovery	dv/dt (Note 4)	dv/dt	2.6	V/ns
Power Dissipation		PD	32	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L = 30mH, I_{AS} = 3.3A, V_DD = 50V, R_G = 25 Ω Starting T_J = 25°C

4. I_{SD} \leq 5.0A, di/dt \leq 200A/µs, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C

THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	θ _{JC}	3.9	°C/W	

Note: Device mounted on FR-4 substrate P_C board, 2oz copper, with 1inch square copper plate.

■ ELECTRICAL CHARACTERISTICS (T_J = 25°C, unless otherwise specified)

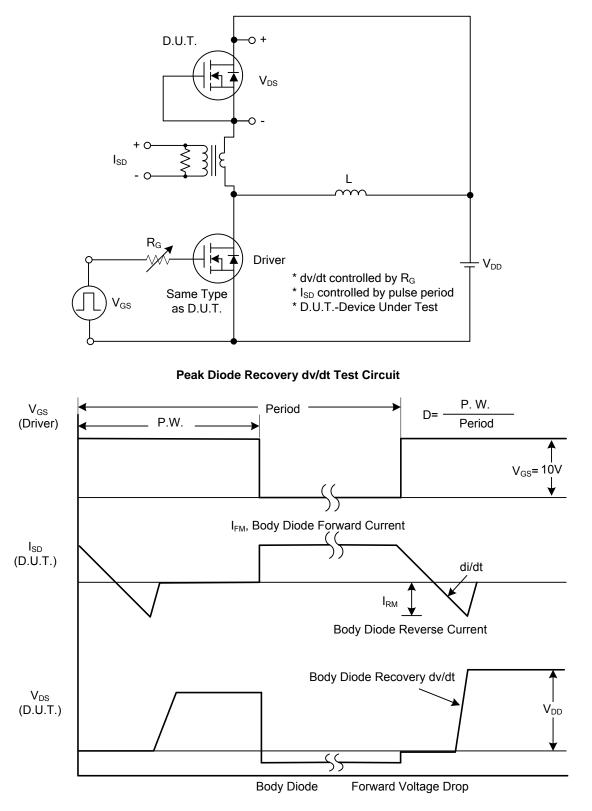
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V, I _D = 250μA	600			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =600V, V _{GS} =0V			10	μA
Cata Source Leakage Current	Forward	1	V_{GS} =30V, V_{DS} =0V			100	nA
Gate-Source Leakage Current	Reverse	I _{GSS}	V _{GS} =-30V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250µA	2.0		4.0	V
Static Drain-Source On-State Resis	stance	R _{DS(ON)}	V _{GS} =10V, I _D =2.5A			2.5	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance	nput Capacitance				535		pF
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =25V, f=1.0 MHz		59		pF
Reverse Transfer Capacitance		C _{RSS}			5		pF
SWITCHING CHARACTERISTICS	6						
otal Gate Charge (Note 1)		Q_G			18		nC
Gateource Charge		Q_{GS}	V_{DS} =520V, V_{GS} =10V, I_{D} =5A		7		nC
Gate-Drain Charge		Q_{GD}	I _G =1mA (Note 1, 2)		4		nC
Turn-on Delay Time (Note 1)		t _{D(ON)}			8		ns
Rise Time		t _R	V _{DS} =100V, V _{GS} =10V, I _D =5A,		16		ns
Turn-off Delay Time		t _{D(OFF)}	R _G =25Ω (Note 1, 2)		32		ns
all-Time		t _F			25		ns
SOURCE- DRAIN DIODE RATING	S AND CH	ARACTERIS	TICS				
Maximum Body-Diode Continuous	Current	ls				5	Α
Maximum Body-Diode Pulsed Curr	ent	I _{SM}				10	Α
Drain-Source Diode Forward Voltage	ge (Note 1)	V_{SD}	V _{GS} =0V, I _S =5A			1.4	V
Reverse Recovery Time (Note 1)		t _{rr}	V _{GS} =0V, I _S =5A,		266		ns
Reverse Recovery Charge		Qrr	dl⊧/dt=100A/µs (Note1)		4.9		μC
Notes: 1 Pulse Test · Pulse width		ty cyclo $\leq 2\%$					

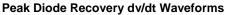
Notes: 1. Pulse Test : Pulse width \leq 300µs, Duty cycle \leq 2%.

2. Essentially independent of operating temperature.



■ TEST CIRCUITS AND WAVEFORMS

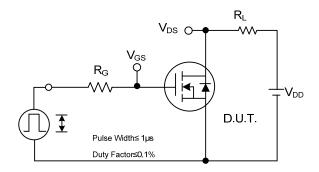




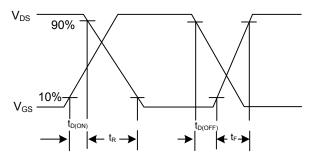


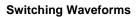
 V_{GS}

TEST CIRCUITS AND WAVEFORMS



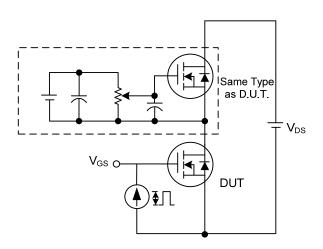
Switching Test Circuit



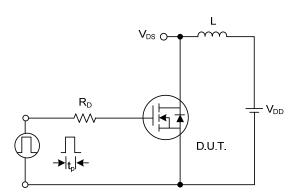


 Q_{G}

 Q_{GD}



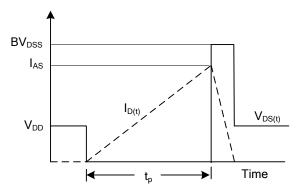
Gate Charge Test Circuit



Unclamped Inductive Switching Test Circuit

Charge





Unclamped Inductive Switching Waveforms



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